Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/683,731	HAAS ET AL.
Examiner	Art Unit

3744

Chen-Wen Jiang

SEARCHED					
Class	Subclass	Date	Examiner		
62	86 87				
	80 93				
	401				
	402				
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165	103		,		
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	122	9/1/2005	CJ.		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search Note Attached Inventor Searched	9/1/2005	cı		
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